

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination LAI ET AL.	
			Examiner Truc T. T. Nguyen	Art Unit 2833	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,669,494	12-2003	Abe, Kiyoshi	439/159
*	B	US-6,655,973	12-2003	Ji et al.	439/159
*	C	US-6,652,301	11-2003	Harasawa et al.	439/159
*	D	US-6,609,919	08-2003	Ito et al.	439/159
*	E	US-6,592,385	07-2003	Chen, Ming-Ching	439/159
*	F	US-6,537,090	03-2003	Ozawa, Hiroshi	439/159
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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